

**INFORMATION DISCLOSURE
STATEMENT BY APPLICANT**

(Not for submission under 37 CFR 1.99)

Application Number	10629301
Filing Date	2003-07-28
First Named Inventor	Lewis B. Aronson
Art Unit	2613
Examiner Name	Hanh Phan
Attorney Docket Number	15436.247.2.1.3

U.S. PATENTS

Examiner Initials*	Cite No.	Patent Number	Issue Date	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
/HP/	1	4489477	1984-12-25	Chik et al	
/HP/	2	6977517	2005-12-20	Miao et al	
/HP/	3	7019548	2006-03-28	Miao et al	
/HP/	4	7155127	2006-12-26	Akimoto	
/HP/	5				

U.S. PATENT APPLICATION PUBLICATIONS

Examiner Initials*	Cite No.	Publication Number	Publication Date	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
	1	20040076114	2004-04-22	Miriello	

FOREIGN PATENT DOCUMENTS

Examiner Initials*	Cite No.	Foreign Patent Document	Country Code	Publication Date	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T 1
/HP/	1	2005006575	WO	2005-01-20	Finisar Corp		<input type="checkbox"/>
/HP/	2	1503232	EP	2004-07-27	Emcore Corp		
/HP/	3	2004135106	JP	2004-04-30	Hitachi Ltd		
/HP/	4	224406	TW	2004-11-21	Hon Hai Prec Ind Co Ltd		
/HP/	5	555297	TW	2003-09-21		Could not obtain copy	
/HP/	6	0203226	WO	2002-05-09			
/HP/	7	02704344	EP	2004-10-05			
/HP/	8	040117254	EP	2004-10-05			

FOREIGN OFFICE ACTION / NOTICE OF ALLOWANCE DOCUMENTS

Examiner Initials*	Cite No.	Application Number	Mail Date	Document
	1			

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NON PATENT LITERATURE DOCUMENTS

Examiner Initials*	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium catalog, etc.) date, page(s), volume-issue number(s), publisher, city and/or country where published	T ¹
/HP/	1	HAWTHORNE: "850nm Proton VCSEL Reliability Study" Technical Publications and Application Notes, Advances Optical Components (Finisar Corp), Issue 2, September 2001, pgs 1-7, Richardson, TX	<input type="checkbox"/>
/HP/	2	MECHERLE G S ET AL: "Considerations for Accelerated Laser Diode Life Testing" Proceedings of the Spie, Spie, Bellingham, VA, vol. 717, 1986, pgs 53-62	
/HP/	3	TEBBI O ET AL: "Comparitive study of accelerated testing models, applications in mechanics" 2001 IEEE International Conference on Systems Man and Cybernetics SMC 2001. Tucson, AZ Oct 7-10, 2001, IEEE International Conference on Systems, Man and Cybernetics, New York, NY: IEEE, US, vol 1 of 5 Oct 7, 2001 pgs 2099-2104	
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OFFICE ACTION / NOTICE OF ALLOWANCE DOCUMENTS

Examiner Initials*	Cite No.	Application Number	Mail Date	Document
/HP/	1	11118172	2008-09-04	Office Action
/HP/	2	10629302	2008-01-25	Restriction Requirement
/HP/	3	11073452	2008-08-07	Office Action
/HP/	4	11118172	2008-03-25	Office Action
/HP/	5	11073452	2007-12-31	Office Action
/HP/	6	10629302	2008-05-02	Office Action
/HP/	7	10884334	2008-01-16	Office Action
/HP/	8	10884334	2008-07-10	Office Action

EXAMINER SIGNATURE

Examiner Signature	/Hanh Phan/	Date Considered	03/15/2009
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through a citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

¹Applicant is to place a check mark here if English language translation is attached.